

RF Test Report

For

Applicant Name:

Address:

EUT Name:

Brand Name:

Model Number:

SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD A2 2F BUILDNG ENET NEW INDUSTRIAL PARK, DAFU INDUSTRIAL ZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX China Smart Phone OUKITEL C57

Series model number C57 S,C57 Pro,C57 Plus,C57 Ultra

Issued By

Company Name:

BTF Testing Lab (Shenzhen) Co., Ltd.

Address:

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Report Number: Test Standards: BTF240729R00902 47 CFR Part 15.247

Test Conclusion: FCC ID: Test Date: Date of Issue: Pass 2ANMU-C57 2024-07-30 to 2024-08-22 2024-08-22

Test By:

SSXX.guo

Ssxx.guo/ Tester

2024-08-2

2024-08-22

Ale the

Ace Xie / Project Enginee

Ryan.CJ / EMC Manager

Prepared By:

Date:

Approved By:

Date:

Note: A	II the	test	results	in this	report	only	related	to the	testing	samples.	Which	can be	duplicated	d complete	y for the	legal	use with	approva	l of
applica	nt; it s	shall i	not be r	eprodu	iced exc	cept i	n full w	ithout	the writt	en approv	al of B1	F Test	ing Lab (Sl	nenzhen) C	o., Ltd., .	All the	objectior	ns should	be
raised w	vithin	thirty	' days fr	om the	date of	f issu	e. To va	lidate	the repo	ort, you ca	n conta	ct us.							

Lab (Shenzhe

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Test Report Number: BTF240729R00902

Revision History					
Version	Issue Date	Revisions Content			
R_V0	2024-08-22	Original			

Note: Once the revision has been made, then previous versions reports are invalid.

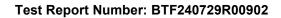




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1 Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.			
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China			
Phone Number:	+86-0755-23146130			
Fax Number:	+86-0755-23146130			

1.2 Identification of the Responsible Testing Location

BTF Testing Lab (Shenzhen) Co., Ltd.			
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou			
Community, Songgang Street, Bao'an District, Shenzhen, China			
+86-0755-23146130			
+86-0755-23146130			
518915			
CN1330			

1.3 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

(5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



2 Product Information

2.1 Application Information

Company Name:	SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD
Address:	A2 2F BUILDNG ENET NEW INDUSTRIAL PARK, DAFU INDUSTRIAL ZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX China

2.2 Manufacturer Information

Company Name:	SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD		
Address:	A2 2F BUILDNG ENET NEW INDUSTRIAL PARK, DAFU INDUSTRIAL ZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX China		

2.3 Factory Information

Company Name:	SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO., LTD
Address:	A2 2F BUILDNG ENET NEW INDUSTRIAL PARK, DAFU INDUSTRIAL ZONE, GUANLAN, LONGHUA SHENZHEN, 518XXX China

2.4 General Description of Equipment under Test (EUT)

EUT Name:	Smart Phone
Test Model Number:	C57
Series model name	C57 S,C57 Pro,C57 Plus,C57 Ultra
Description of model name differentiation	Only the model name is different, the others are the same.

2.5 Technical Information

Power Supply:	DC 5V from adaptor or DC 4.4V from battery
Power Adaptor:	Model:ZFX021 Input:100-240V, 50/60Hz 0.2A Output:DC5.0V 1000mA
Operation Frequency:	2402MHz to 2480MHz
Number of Channels:	40
Modulation Type:	GFSK
Antenna Type:	PIFA Antenna
Antenna Gain#:	0.65dBi
Note:	

#: The antenna gain provided by the applicant, and the laboratory will not be responsible for the accumulated calculation results which covers the information provided by the applicant.



Summary of Test Results 3

3.1 **Test Standards**

The tests were performed according to following standards:

47 CFR Part 15.247: Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

3.2 Uncertainty of Test

Item	Measurement Uncertainty
Conducted Emission (150 kHz-30 MHz)	±2.64dB
Occupied Bandwidth	±69kHz
Transmitter Power, Conducted	±0.87dB
Power Spectral Density	±0.69dB
Conducted Spurious Emissions	±0.95dB
Radiated Spurious Emissions (above 1GHz)	1-6GHz: ±3.94dB 6-18GHz: ±4.16dB
Radiated Spurious Emissions (30M - 1GHz)	±4.12dB

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Summary of Test Result 3.3

Item	Standard	Requirement	Result
Antenna requirement	47 CFR Part 15.247	47 CFR 15.203	Pass
Conducted Emission at AC power line	47 CFR Part 15.247	47 CFR 15.207(a)	Pass
Occupied Bandwidth	47 CFR Part 15.247	47 CFR 15.247(a)(2)	Pass
Maximum Conducted Output Power	47 CFR Part 15.247	47 CFR 15.247(b)(3)	Pass
Power Spectral Density	47 CFR Part 15.247	47 CFR 15.247(e)	Pass
Emissions in non-restricted frequency bands	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
Band edge emissions (Radiated)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
Emissions in frequency bands (below 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
Emissions in frequency bands (above 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass

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4 Test Configuration

4.1 Test Equipment List

Conducted Emission at AC power line								
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
Pulse Limiter	SCHWARZBECK	VTSD 9561-F	00953	2023-11-13	2024-11-12			
Coaxial Switcher	SCHWARZBECK	CX210	CX210	2023-11-13	2024-11-12			
V-LISN	SCHWARZBECK	NSLK 8127	01073	2023-11-16	2024-11-15			
LISN	AFJ	LS16/110VAC	16010020076	2023-11-16	2024-11-15			
EMI Receiver	ROHDE&SCHWA RZ	ESCI3	101422	2023-11-15	2024-11-14			

Occupied Bandwidth Maximum Conducted Power Spectral Densi Emissions in non-res	ity .	ands			
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
RFTest software	/	V1.00	/	/	/
RF Control Unit	Techy	TR1029-1	/	2023-11-13	2024-11-12
RF Sensor Unit	Techy	TR1029-2	/	2023-11-13	2024-11-12
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2023-11-16	2024-11-15
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2023-11-13	2024-11-12
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2023-11-16	2024-11-15
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2023-11-16	2024-11-15



Band edge emissions Emissions in frequen		GHz)			
Emissions in frequen Equipment			Inventory No	Cal Date	Cal Due Date
Coaxial cable Multiflex 141		N/SMA 0.5m	517386	2023-11-13	2024-11-12
Preamplifier	SCHWARZBECK	BBV9744	00246	2023-11-13	2024-11-12
RE Cable	REBES Talent	UF1-SMASMAM-1 0m	21101566	2023-11-13	2024-11-12
RE Cable	REBES Talent	UF2-NMNM-10m	21101570	2023-11-13	2024-11-12
RE Cable	REBES Talent	UF1-SMASMAM-1 m	21101568	2023-11-13	2024-11-12
RE Cable	REBES Talent	UF2-NMNM-1m	21101576	2023-11-13	2024-11-12
RE Cable	REBES Talent	UF2-NMNM-2.5m	21101573	2023-11-13	2024-11-12
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	2023-11-13	2024-11-12
Horn Antenna	SCHWARZBECK	BBHA9170	01157	2023-11-13	2024-11-12
EMI TEST RECEIVER	ROHDE&SCHWA RZ	ESCI7	101032	2023-11-16	2024-11-15
SIGNAL ANALYZER	ROHDE&SCHWA RZ	FSQ40	100010	2023-11-16	2024-11-15
POSITIONAL CONTROLLER	SKET	PCI-GPIB	1	2023-11-13	2024-11-12
Broadband Preamplilifier	SCHWARZBECK	BBV9718D	00008	2023-11-16	2024-11-15
Horn Antenna	SCHWARZBECK	BBHA9120D	2597	2023-11-16	2024-11-15
EZ_EMC	Frad	FA-03A2 RE+	/	1	1
POSITIONAL CONTROLLER	SKET	PCI-GPIB	1	2023-11-13	2024-11-12
Log periodic antenna	SCHWARZBECK	VULB 9168	01328	2023-11-13	2024-11-12



4.2 Test Auxiliary Equipment

The EUT was tested as an independent device.

4.3 Test Mode	es
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No.	Test Modes	Description
TM1	TX mode	Keep the EUT connect to AC power line and works in continuously transmitting mode with GFSK modulation.



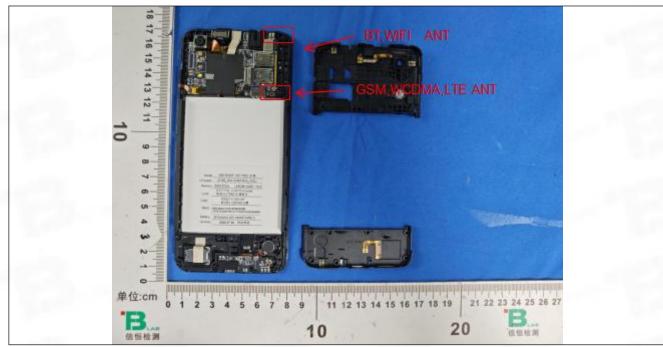
5 Evaluation Results (Evaluation)

5.1 Antenna requirement

Refer to 47 CFR Part 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

5.1.1 Conclusion:

Test Requirement:





6 Radio Spectrum Matter Test Results (RF)

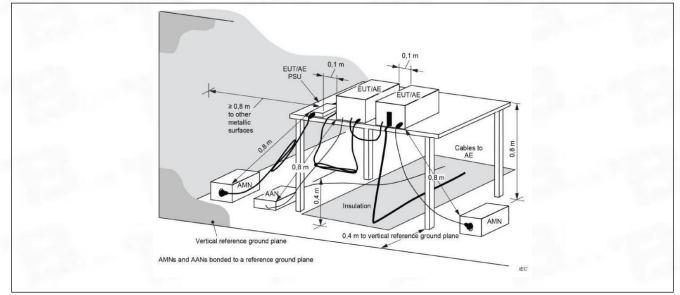
6.1 Conducted Emission at AC power line

Test Requirement:	Refer to 47 CFR 15.207(a), Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohms line impedance stabilization network (LISN).					
Test Method:	ANSI C63.10-2013 section 6.2					
Test Limit:	Frequency of emission (MHz) 0.15-0.5 0.5-5	Conducted limit (dBµV)Quasi-peakAverage66 to 56*56 to 46*5646				
	5-30 *Decreases with the logarithm of th	60	50			
Procedure:	Refer to ANSI C63.10-2013 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices					

6.1.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.7 °C
Humidity:	52 %
Atmospheric Pressure:	1010 mbar

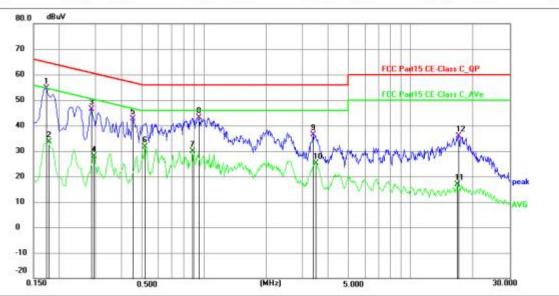
6.1.2 Test Setup Diagram:





6.1.3 Test Data:

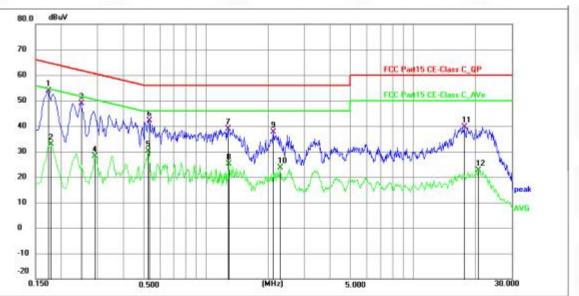
TM1 / Line: Line / Band: 2400-2483.5 MHz / BW: 1 / CH: M



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1 *	0.1723	44.02	10.49	54.51	64.85	-10.34	QP	P	
2	0.1770	23.02	10.51	33.53	54.63	-21.10	AVG	P	
3	0.2850	35.94	10.56	46.50	60.67	-14.17	QP	P	
4	0.2940	17.36	10.56	27.92	50.41	-22.49	AVG	P	
5	0.4515	32.05	10.57	42.62	56.85	-14.23	QP	P	
6	0.5190	20.99	10.59	31.58	46.00	-14.42	AVG	P	
7	0.8831	19.26	10.68	29.94	46.00	-16.06	AVG	P	
8	0.9465	32.40	10.67	43.07	56.00	-12.93	QP	P	51
9	3.3720	25.68	10.64	36.32	56.00	-19.68	QP	P	
10	3.4620	14.59	10.63	25.22	46.00	-20.78	AVG	P	
11	16.9169	5.96	10.99	16.95	50.00	-33.05	AVG	P	5
12	17.0250	24.86	10.99	35.85	60.00	-24.15	QP	P	le .

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TM1 / Line: Neutral / Band: 2400-2483.5 MHz / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1 *	0.1723	43.28	10.49	53.77	64.85	-11.08	QP	P	
2	0.1770	22.42	10.51	32.93	54.63	-21.70	AVG	P	
3	0.2490	38.39	10.56	48.95	61.79	-12.84	QP	P	
4	0.2893	17.58	10.56	28.14	50.54	-22.40	AVG	P	
5	0.5231	19.57	10.59	30.16	46.00	-15.84	AVG	P	
6	0.5322	31.61	10.60	42.21	56.00	-13.79	QP	P	
7	1.2882	28.24	10.66	38.90	56.00	-17.10	QP	P	
8	1.2930	14.35	10.66	25.01	46.00	-20.99	AVG	P	
9	2.1120	26.83	10.68	37.51	56.00	-18.49	QP	P	
10	2.2964	13.00	10.67	23.67	46.00	-22.33	AVG	P	
11	17.7225	28.78	10.95	39.73	60.00	-20.27	QP	P	
12	20.8094	11.49	11.08	22.57	50.00	-27.43	AVG	P	



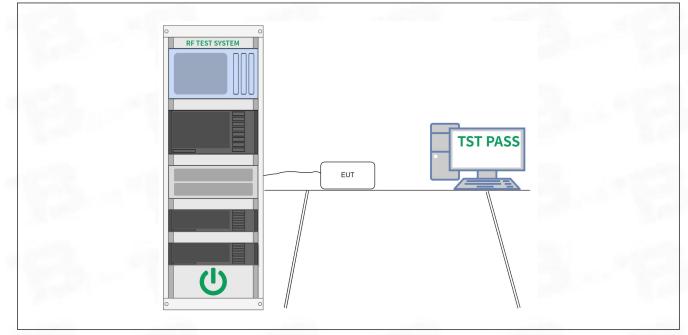
6.2 Occupied Bandwidth

Test Dequirement	
Test Requirement:	47 CFR 15.247(a)(2)
Test Method:	ANSI C63.10-2013, section 11.8 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(a)(2), Systems using digital modulation techniques may operate in the 902-928 MHz, and 2400-2483.5 MHz bands. The minimum 6 dB bandwidth shall be at least 500 kHz.
Procedure:	 a) Set RBW = 100 kHz. b) Set the VBW >= [3 × RBW]. c) Detector = peak. d) Trace mode = max hold. e) Sweep = auto couple. f) Allow the trace to stabilize. g) Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

6.2.1 E.U.T. Operation:

Operating Environment:	
Temperature:	22.9 °C
Humidity:	52.7 %
Atmospheric Pressure:	1010 mbar

6.2.2 Test Setup Diagram:



6.2.3 Test Data:



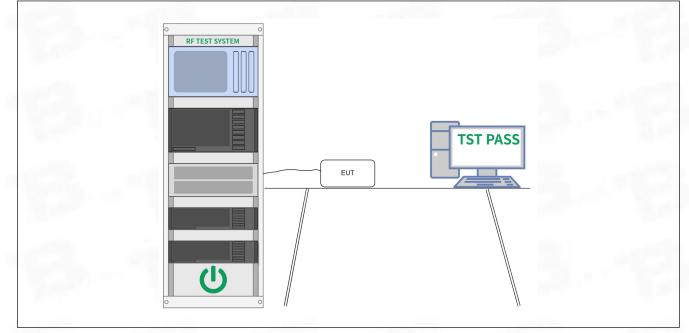
6.3 Maximum Conducted Output Power

	-
Test Requirement:	47 CFR 15.247(b)(3)
Test Method:	ANSI C63.10-2013, section 11.9.1 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(b)(3), For systems using digital modulation in the 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz bands: 1 Watt. As an alternative to a peak power measurement, compliance with the one Watt limit can be based on a measurement of the maximum conducted output power. Maximum Conducted Output Power is defined as the total transmit power delivered to all antennas and antenna elements averaged across all symbols in the signaling alphabet when the transmitter is operating at its maximum power control level. Power must be summed across all antennas and antenna elements. The average must not include any time intervals during which the transmitter is off or is transmitting at a reduced power level. If multiple modes of operation are possible (e.g., alternative modulation methods), the maximum conducted output power is the highest total transmit power occurring in any mode.
Procedure:	ANSI C63.10-2013, section 11.9.1 Maximum peak conducted output power

6.3.1 E.U.T. Operation:

Operating Environment:	
Temperature:	22.9 °C
Humidity:	52.7 %
Atmospheric Pressure:	1010 mbar

6.3.2 Test Setup Diagram:



6.3.3 Test Data:



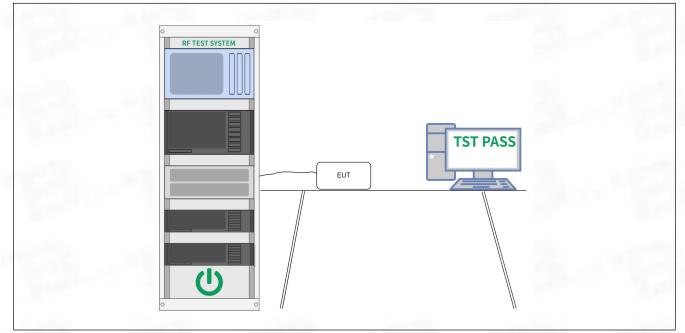
6.4 Power Spectral Density

Test Requirement:	47 CFR 15.247(e)
Test Method:	ANSI C63.10-2013, section 11.10 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(e), For digitally modulated systems, the power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission. This power spectral density shall be determined in accordance with the provisions of paragraph (b) of this section. The same method of determining the conducted output power shall be used to determine the power spectral density.
Procedure:	ANSI C63.10-2013, section 11.10, Maximum power spectral density level in the fundamental emission

6.4.1 E.U.T. Operation:

Operating Environment:	
Temperature:	22.9 °C
Humidity:	52.7 %
Atmospheric Pressure:	1010 mbar

6.4.2 Test Setup Diagram:



6.4.3 Test Data:



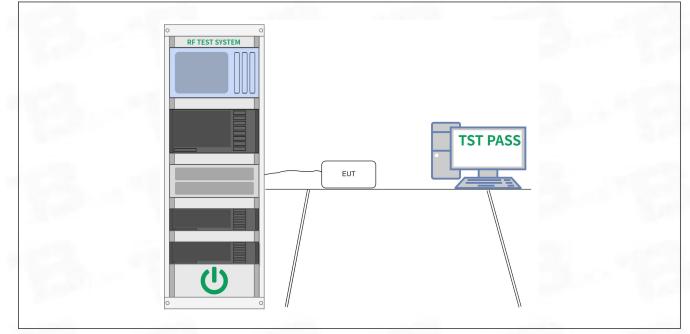
6.5 Emissions in non-restricted frequency bands

Test Requirement:	47 CFR 15.247(d), 15.209, 15.205
Test Method:	ANSI C63.10-2013 section 11.11 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(d), In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Procedure:	ANSI C63.10-2013 Section 11.11.1, Section 11.11.2, Section 11.11.3

6.5.1 E.U.T. Operation:

Operating Environment:	
Temperature:	22.9 °C
Humidity:	52.7 %
Atmospheric Pressure:	1010 mbar

6.5.2 Test Setup Diagram:



6.5.3 Test Data:



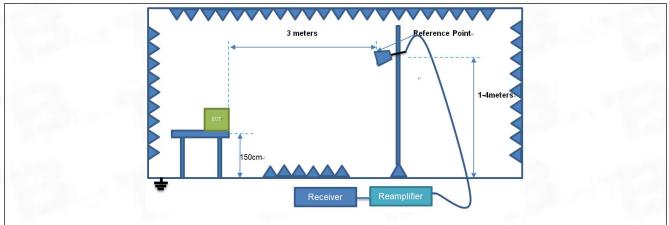
6.6 Band edge emissions (Radiated)

Test Requirement:	restricted bands, as define), In addition, radiated emission ed in § 15.205(a), must also co n § 15.209(a)(see § 15.205(c)).	mply with the radiated		
Test Method:	ANSI C63.10-2013 section 6.10 KDB 558074 D01 15.247 Meas Guidance v05r02				
0.009-0	Frequency (MHz)	Field strength (microvolts/meter) 2400/F(kHz)	Measurement distance (meters) 300		
	0.490-1.705	24000/F(kHz)	30		
	1.705-30.0	30	30		
	30-88	100 **	3		
	88-216	150 **			
	216-960	200 **	3		
Test Limit:	Above 960	500	3		
	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.				
Procedure:	ANSI C63.10-2013 section	n 6.10.5.2			

6.6.1 E.U.T. Operation:

Operating Environment:	
Temperature:	25.7 °C
Humidity:	48.1 %
Atmospheric Pressure:	1010 mbar

6.6.2 Test Setup Diagram:





6.6.3 Test Data:

Note: All the mode have been tested, and only the worst case of mode are in the report

Frequency	Reading Level	Correct Factor	Measurement	Limits	Over	Detector	Polarization
(MHz)	(dBµV)	(dB/m)	(dBµV/m)	(dBµV/m)	(dB)	Peak/AVG	H/V
	1.0		GFSK – Low	/ band-edge			
(MHz)	(dBµV)	(dB/m)	(dBµV/m)	(dBµV/m)	(dB)	Peak/AVG	H/V
2310	87.40	-49.61	37.79	74	-36.21	Peak	V
2310	77.47	-49.61	27.86	54	-26.14	AVG	V
2390	87.36	-49.5	37.86	74	-36.14	Peak	V
2390	77.21	-49.5	27.71	54	-26.29	AVG	V
2310	87.38	-49.61	37.77	74	-36.23	Peak	Н
2310	77.22	-49.61	27.61	54	-26.39	AVG	Н
2390	87.33	-49.5	37.83	74	-36.17	Peak	Н
2390	77.16	-49.5	27.66	54	-26.34	AVG	Н
			GFSK – High	n band-edge			
2483.5	85.58	-49.5	36.08	74	-37.92	Peak	V
2483.5	74.19	-49.5	24.69	54	-29.31	AVG	V
2500	85.49	-49.49	36.00	74	-38.00	Peak	V
2500	74.44	-49.49	24.95	54	-29.05	AVG	V
2483.5	85.55	-49.5	36.05	74	-37.95	Peak	Н
2483.5	74.12	-49.5	24.62	54	-29.38	AVG	Н
2500	85.28	-49.49	35.79	74	-38.21	Peak	Н
2500	74.44	-49.49	24.95	54	-29.05	AVG	Н



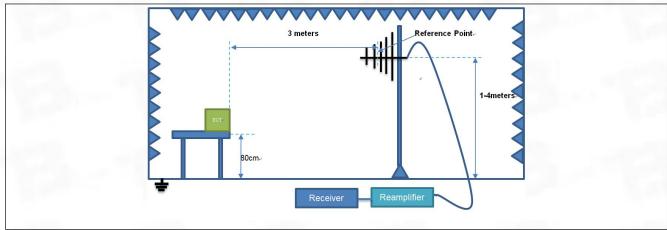
6.7 Emissions in frequency bands (below 1GHz)

Test Requirement:	restricted bands, as defin	d), In addition, radiated emissic led in § 15.205(a), must also co in § 15.209(a)(see § 15.205(c))	omply with the radiated			
Test Method:	ANSI C63.10-2013 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02					
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)			
	0.009-0.490	2400/F(kHz)	300			
	0.490-1.705	24000/F(kHz)	30			
	1.705-30.0	30	30			
	30-88	100 **	3			
	0.009-0.490 0.490-1.705 1.705-30.0 30-88 88-216 216-960 Above 960 ** Except as provided in p radiators operating under 54-72 MHz, 76-88 MHz, 1 these frequency bands is 15.231 and 15.241.	150 **	3			
88-21 216-9 Abov	216-960	200 **	3			
Test Limit:	Above 960	500	3			
	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241.					
	In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.					
Procedure:	ANSI C63.10-2013 section	on 6.6.4	1.00			

6.7.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.6 °C
Humidity:	52 %
Atmospheric Pressure:	1010 mbar

6.7.2 Test Setup Diagram:

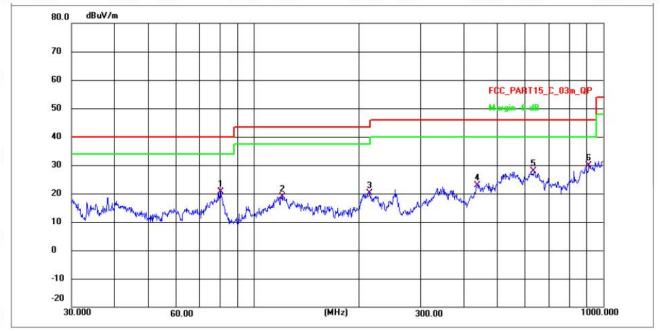


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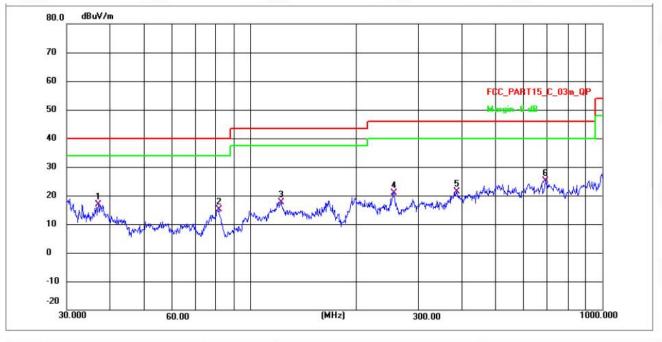
6.7.3 Test Data:

TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: M



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	80.2211	29.94	-9.27	20.67	40.00	-19.33	QP	P
2	120.9110	41.23	-22.27	18.96	43.50	-24.54	QP	Р
3	215.2675	41.42	-21.38	20.04	43.50	-23.46	QP	Р
4	436.3541	42.38	-19.52	22.86	46.00	-23.14	QP	Р
5	635.0193	45.95	-18.08	27.87	46.00	-18.13	QP	Р
6 *	912.8620	45.95	-16.14	29.81	46.00	-16.19	QP	Р





TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	36.9600	26.54	-9.65	16.89	40.00	-23.11	QP	P
2	81.2116	24.33	-9.27	15.06	40.00	-24.94	QP	Р
3	122.4040	39.91	-22.26	17.65	43.50	-25.85	QP	Р
4	255.6230	<mark>41.94</mark>	-21.00	20.94	46.00	-25.06	QP	P
5	386.6338	41.39	-19.93	21.46	46.00	-24.54	QP	Р
6 *	690.7744	42.79	-17.68	25.11	46.00	-20.89	QP	Р



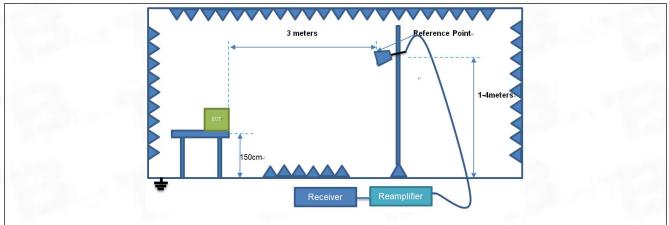
6.8 Emissions in frequency bands (above 1GHz)

Test Requirement:	15.205(a), must also cor	In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).						
Test Method:	ANSI C63.10-2013 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02							
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)					
	0.009-0.490	2400/F(kHz)	300					
	0.490-1.705	24000/F(kHz)	30					
	1.705-30.0	30	30					
	30-88	100 **	3					
	88-216	150 **	3					
	216-960	200 **	3					
Test Limit:	Above 960	500	3					
	radiators operating under 54-72 MHz, 76-88 MHz, these frequency bands i 15.231 and 15.241. In the emission table ab The emission limits show employing a CISPR qua 110–490 kHz and above	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands						
D		ents employing an average det						
Procedure:	ANSI C63.10-2013 sect	on 6.6.4						

6.8.1 E.U.T. Operation:

Operating Environment:								
Temperature:	25.7 °C							
Humidity:	48.1 %							
Atmospheric Pressure:	1010 mbar							

6.8.2 Test Setup Diagram:





6.8.3 Test Data:

Note: All the mode have been tested, and only the worst case of mode are in the report

Frequency	Reading Level	Correct Factor	Measurement	Limits	Over	Detector	Polarization
(MHz)	(dBµV)	(dB/m)	(dBµV/m)	(dBµV/m)	(dB)	Peak/AVG	H/V
			BLE - 2402 M	Hz TX mode			14.5
4804	87.39	-48.88	38.51	74.00	-35.49	Peak	V
4804	76.72	-48.88	27.84	54.00	-26.16	AVG	V
7206	87.56	-47.21	40.35	74.00	-33.65	Peak	V
7206	76.70	-47.21	29.49	54.00	-24.51	AVG	V
9608	87.37	-45.57	41.80	74.00	-32.20	Peak	V
9608	76.24	-45.57	30.67	54.00	-23.33	AVG	V
4804	87.63	-48.88	38.75	74.00	-35.25	Peak	Н
4804	76.40	-48.88	27.52	54.00	-26.48	AVG	Н
7206	87.59	-47.21	40.38	74.00	-33.62	Peak	Н
7206	76.28	-47.21	29.07	54.00	-24.93	AVG	Н
9608	87.55	-45.57	41.98	74.00	-32.02	Peak	Н
9608	76.47	-45.57	30.90	54.00	-23.10	AVG	Н
			BLE - 2440MI	Hz TX mode			1.1
4880	86.49	-48.83	37.66	74.00	-36.34	Peak	V
4880	75.13	-48.83	26.30	54.00	-27.70	AVG	V
7320	86.61	-46.89	39.72	74.00	-34.28	Peak	V
7320	74.87	-46.89	27.98	54.00	-26.02	AVG	V
9760	89.57	-45.51	44.06	74.00	-29.94	Peak	V
9760	75.42	-45.51	29.91	54.00	-24.09	AVG	V
4880	89.75	-48.83	40.92	74.00	-33.08	Peak	Н
4880	75.70	-48.83	26.87	54.00	-27.13	AVG	Н
7320	89.97	-46.89	43.08	74.00	-30.92	Peak	Н
7320	76.30	-46.89	29.41	54.00	-24.59	AVG	Н
9760	89.42	-45.51	43.91	74.00	-30.09	Peak	Н
9760	75.42	-45.51	29.91	54.00	-24.09	AVG	Н
			BLE - 2480 M	Hz TX mode			
4960	85.79	-48.78	37.01	74.00	-36.99	Peak	V
4960	73.02	-48.78	24.24	54.00	-29.76	AVG	V
7440	85.85	-46.75	39.10	74.00	-34.90	Peak	V
7440	73.05	-46.75	26.30	54.00	-27.70	AVG	V
9920	85.57	-45.45	40.12	74.00	-33.88	Peak	V
9920	73.00	-45.45	27.55	54.00	-26.45	AVG	V
4960	85.61	-48.78	36.83	74.00	-37.17	Peak	Н
4960	72.88	-48.78	24.10	54.00	-29.90	AVG	Н
7440	85.58	-46.75	38.83	74.00	-35.17	Peak	Н

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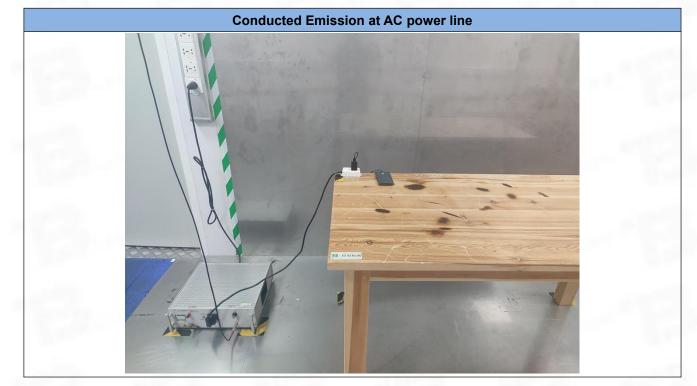


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7440	72.78	-46.75	26.03	54.00	-27.97	AVG	Н
9920	85.69	-45.45	40.24	74.00	-33.76	Peak	Н
9920	73.01	-45.45	27.56	54.00	-26.44	AVG	Н



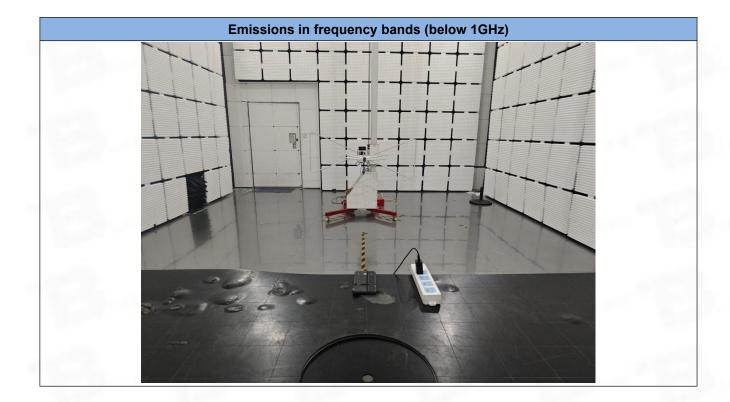
7 Test Setup Photos



Band edge emissions (Radiated) Emissions in frequency bands (above 1GHz)







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Appendix

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1. Duty Cycle

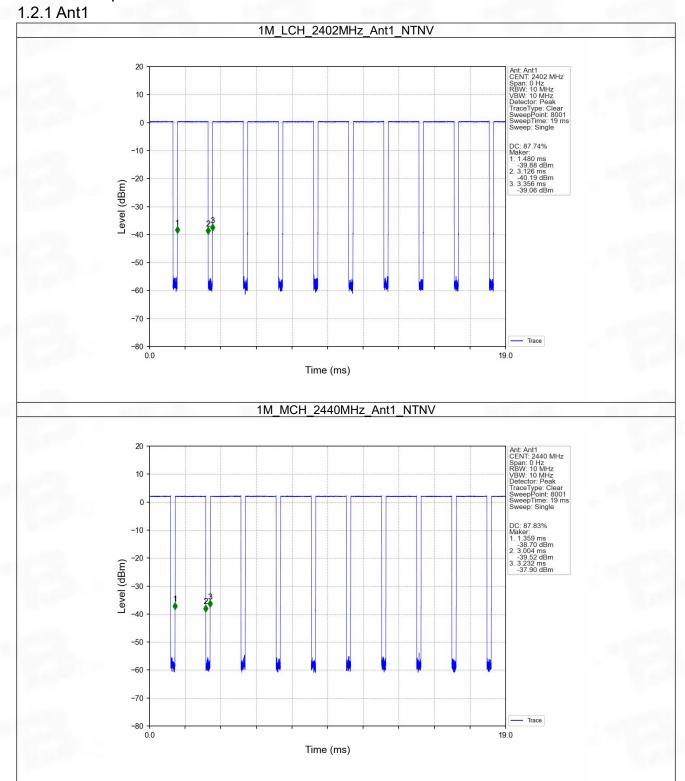
1.1 Test Result

1.1.1 Ant1

Ant1									
Mode	TX	Frequency	T_on	Period	Duty Cycle	Duty Cycle	Max. DC		
wode	Туре	(MHz)	(ms)	(ms)	(%)	Correction Factor (dB)	Variation (%)		
		2402	1.646	1.876	87.74	0.57	0.13		
1M	SISO	2440	1.645	1.873	87.83	0.56	0.13		
		2480	1.646	1.874	87.83	0.56	0.02		

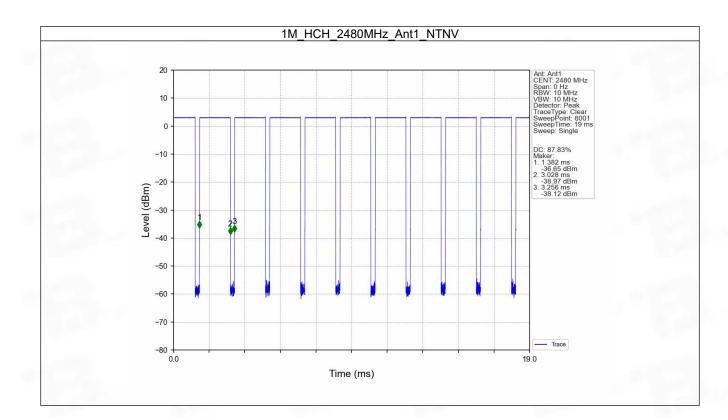


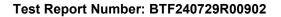
1.2 Test Graph



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2. Bandwidth

2.1 Test Result

2.1.1 OBW

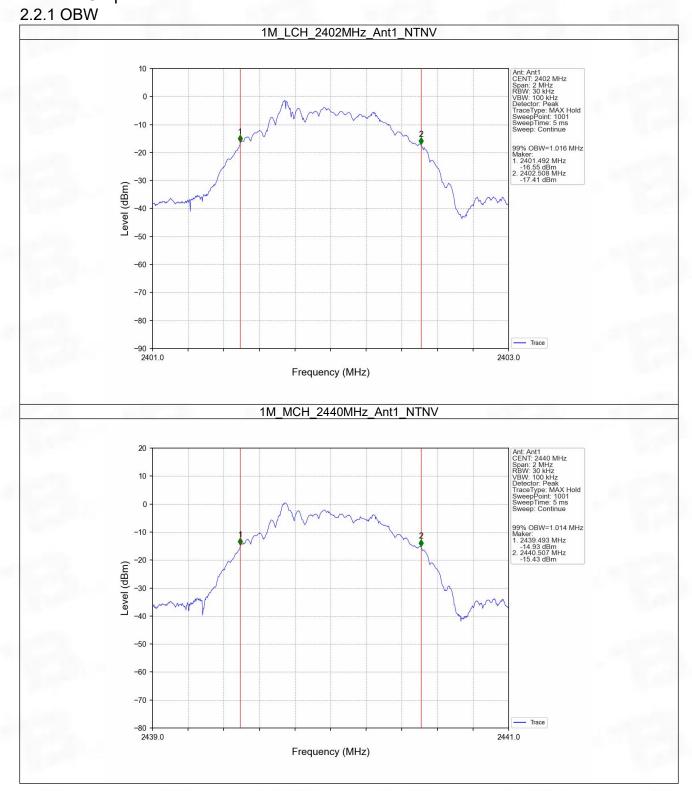
Mode	TX	Frequency	ANT	99% Occupied E	Vardiat	
	Туре	(MHz) AI	ANT	Result	Limit	Verdict
		2402	1	1.016	/	Pass
1M	SISO	2440	1	1.014	1	Pass
		2480	1	1.015	/	Pass

2.1.2 6dB BW

Mode	TX	Frequency ANT		6dB Bandw	Verdict	
Mode	Туре	(MHz) ANT	ANT	Result	Limit	verdict
		2402	1	0.666	>=0.5	Pass
1M	SISO	2440	1	0.666	>=0.5	Pass
		2480	1	0.667	>=0.5	Pass

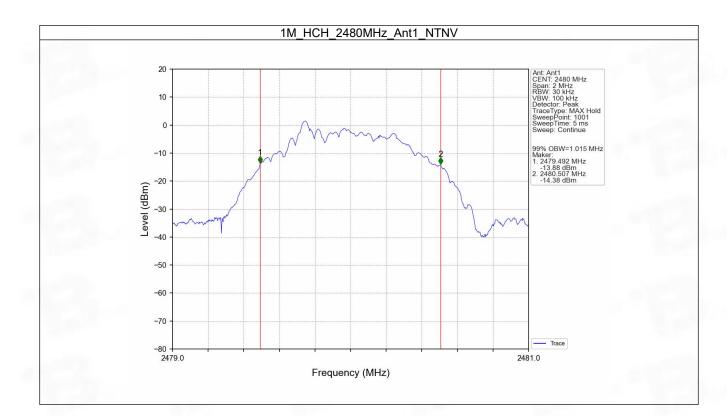


2.2 Test Graph



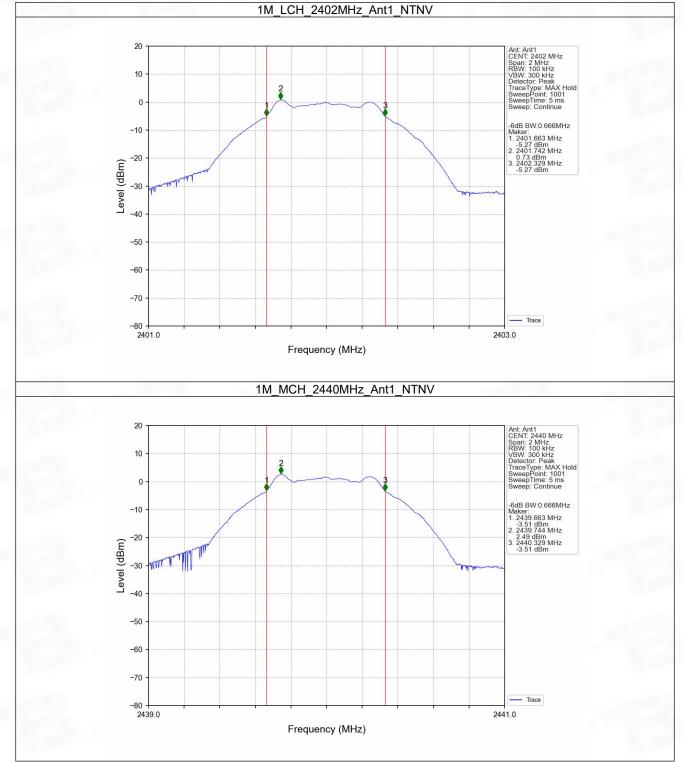
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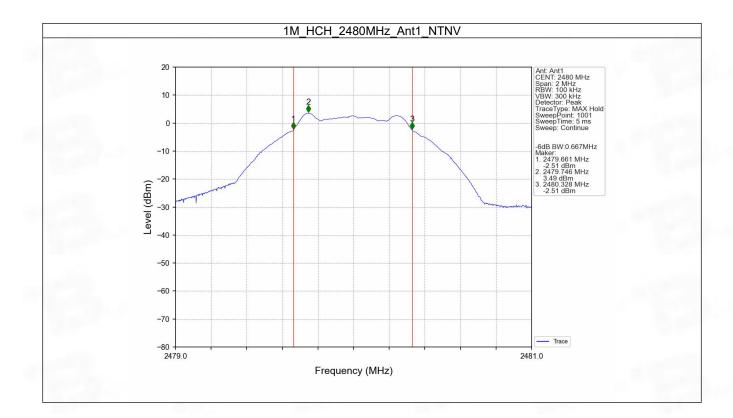


2.2.2 6dB BW



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3. Maximum Conducted Output Power

3.1 Test Result

3.1.1 Power

Mode	TX	Frequency	Maximum Peak Conducted Output Power (dBm)		Verdict
wode	Туре	(MHz)	ANT1	Limit	verdict
1M	SISO	2402	0.52	<=30	Pass
		2440	2.28	<=30	Pass
		2480	3.25	<=30	Pass
Note1: Anten	na Gain: Ant1: 0	.65 dBi:			

4. Maximum Power Spectral Density

4.1 Test Result

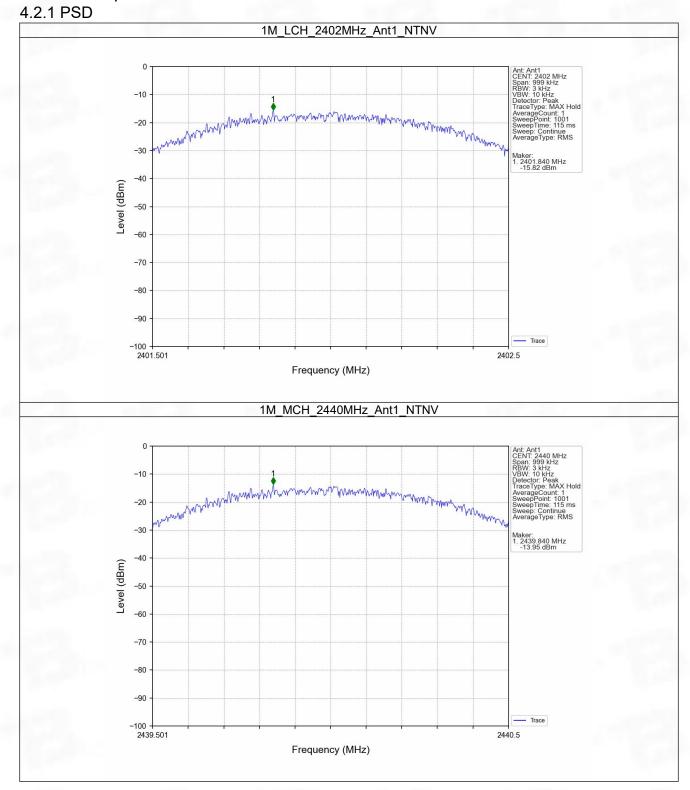
4.1.1 PSD

Mode	TX	Frequency	Maximum PSD (dBm/3kHz)		Verdict
woue	Туре	(MHz)	ANT1	Limit	veruici
		2402	-15.82	<=8	Pass
1M	SISO	2440	-13.95	<=8	Pass
		2480	-12.97	<=8	Pass
Note1: Antenna	Gain: Ant1: 0.65 d	Bi;			

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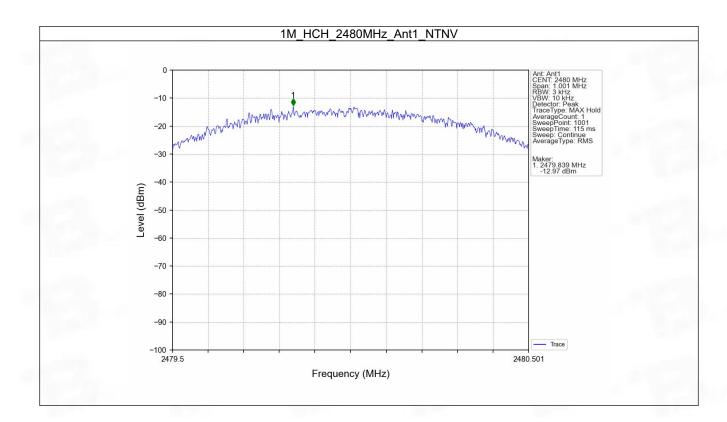


4.2 Test Graph



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5. Unwanted Emissions In Non-restricted Frequency Bands

5.1 Test Result

5.1.1 Ref

Mode	ТХ Туре	Frequency (MHz)	ANT	Level of Reference (dBm)
	SISO	2402	1	0.71
1M		2440	1	2.49
		2480	1	3.48

Note1: Refer to FCC Part 15.247 (d) and ANSI C63.10-2013, the channel contains the maximum PSD level was used to establish the reference level.

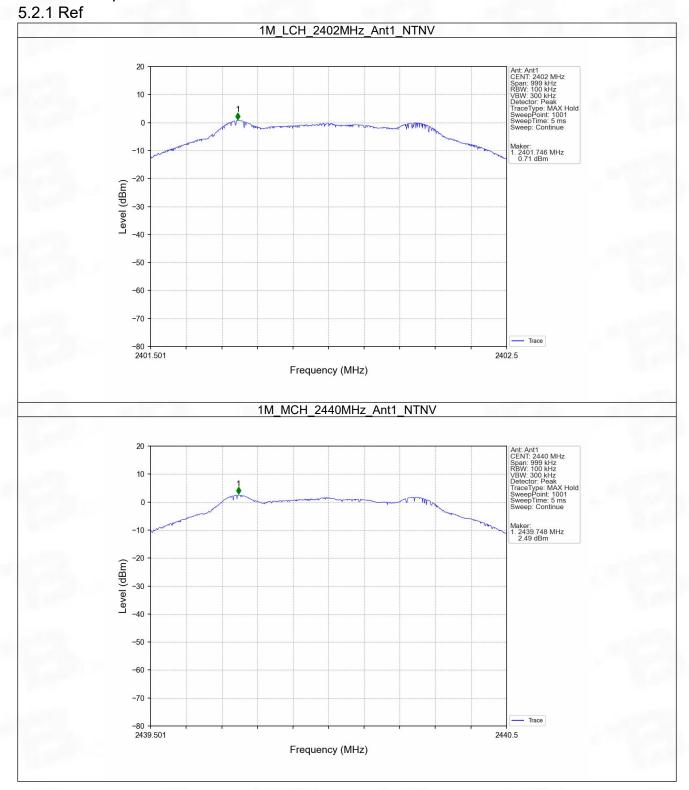
5.1.2 CSE

Mode	ТХ Туре	Frequency (MHz)	ANT	Level of Reference (dBm)	Limit (dBm)	Verdict
		2402	1	3.48	-16.52	Pass
1M	SISO	2440	1	3.48	-16.52	Pass
		2480	1	3.48	-16.52	Pass
	·		000 10 0010		· DOD /	

Note1: Refer to FCC Part 15.247 (d) and ANSI C63.10-2013, the channel contains the maximum PSD level was used to establish the reference level.

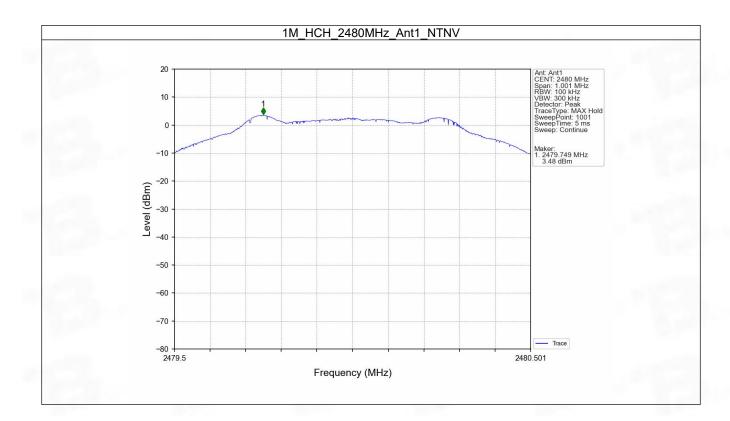


5.2 Test Graph

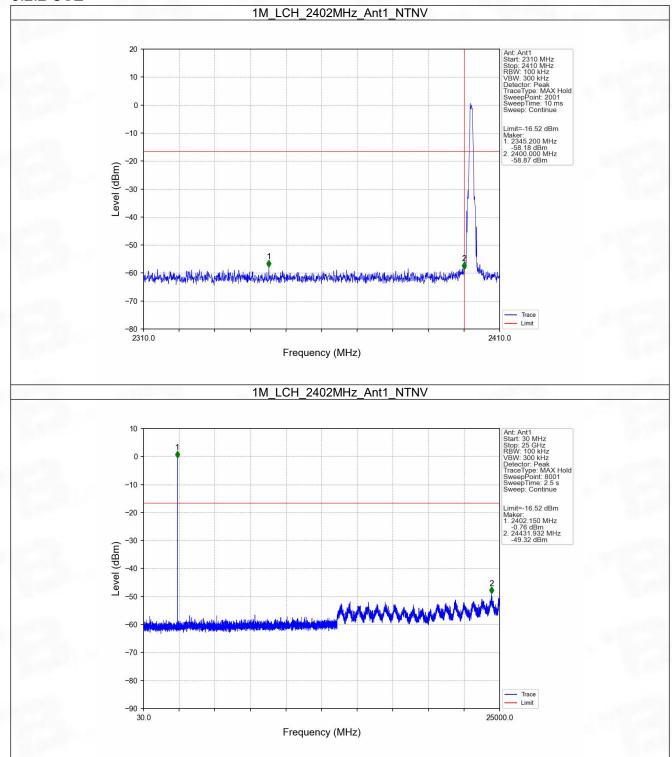


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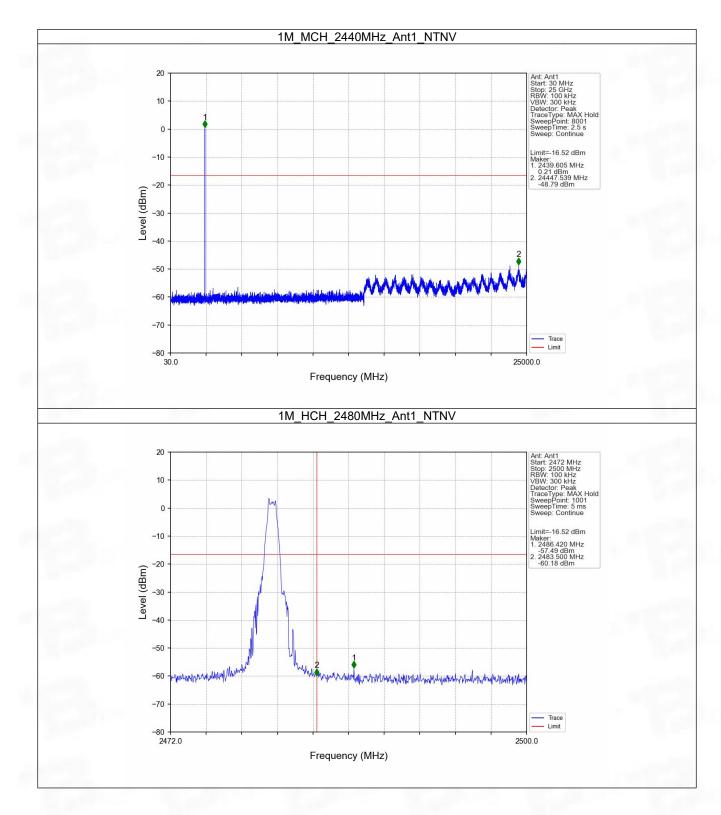






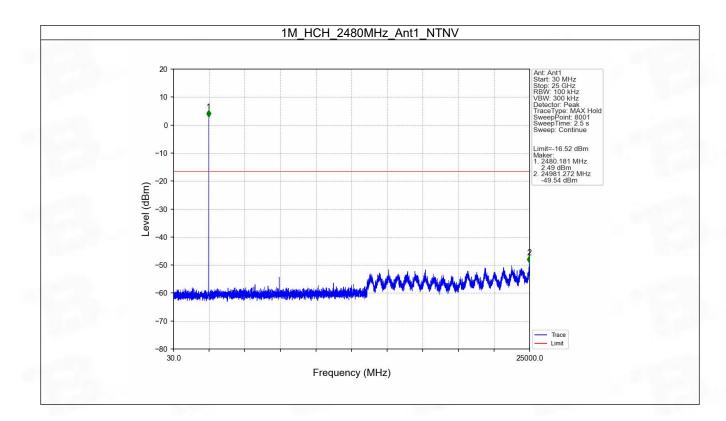
5.2.2 CSE





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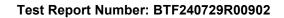
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6. Form731

6.1 Test Result

6.1.1 Form731

Lower Freq (MHz)	High Freq (MHz)	MAX Power (W)	MAX Power (dBm)
2402	2480	0.0021	3.25







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